

## IECEX Quality Assessment Report: NL/DEK/QAR13.0030/00 details

<b>QAR :</b>	
QAR Reference Number *: (automatic numbering)	NL/DEK/QAR13.0030/00
Related QARs:	
Status*:	Issued
QAR Free Reference Number*:	381081800
Audit Date*: (yyyy-mm-dd)	2013-08-05
Date of Issue*: (yyyy-mm-dd)	2013-08-30
Valid until*: (yyyy-mm-dd)	2016-08-30
Site(s) audited*:	Crystal Engineering Corporation 708 Fiero Lane, Suite 9 San Luis Obispo, CA 93401 USA
Issuing ExCB*:	DEK - DEKRA Certification B.V.
Manufacturer*:	Crystal Engineering Corporation 708 Fiero Lane, Suite 9 San Luis Obispo, CA 93401 USA
Country of Manufacture*:	United States of America
Product information*:	Digital Test Gauges and Pressure Recorders
Protection concept*:	Ex i
Related IECEX Certificates: (automatic linking)	<a href="#">IECEX SIR 09.0053X issue: 4 [Current]</a>
Related Certificates: (manual insertion)	KEMA 04 ATEX 1053X FTZU 06ATEX0010X SIRA 09ATEX2008X
Related IECEX Certificates for all previous versions:	-
Comment:	
Attachment:	

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